Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10718279	SCOTT ET AL.
Examiner	Art Unit
Dare, Ryan	2186

SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST(US-PGPUB; USPAT, USOCR; EPO; JPO; DERWENT; IBM_TDB) text search and limited classification search of 711/103,102,173,129,5 and 365/185.33,189.04	11/22/05	RD	
updated EAST search	8/4/06	RD	
EIC NPL and foreign patent search	8/4/06	RD	
EAST(US-PGPUB; USPAT, USOCR; EPO; JPO; DERWENT; IBM_TDB) text search and limited classification search of 711/103,102,173,129,5,2,202,165 and 365/185.33,189.04. See search history.	1/8/07	RD	
Consulted Hong Kim, Primary Examiner class 711	1/8/07	RD	
Consulted Kevin Verbrugge, Primary Examiner class 711	1/8/07	RD	

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			
711	103, EAST text search of US PGPubs	1/7/07	RD			